Applicant(s)/Patent Under Application/Control No. Reexamination 10/631,854 IWATSUKA, SHINJI Notice of References Cited Art Unit Examiner Page 1 of 1 Richard Hanig 2873 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В С US-US-D US-E US-F US-G US-Н US-US-J US-K US-L US-Μ FOREIGN PATENT DOCUMENTS **Document Number** Date Classification * Country Name MM-YYYY Country Code-Number-Kind Code N 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) * U ٧ W X

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